



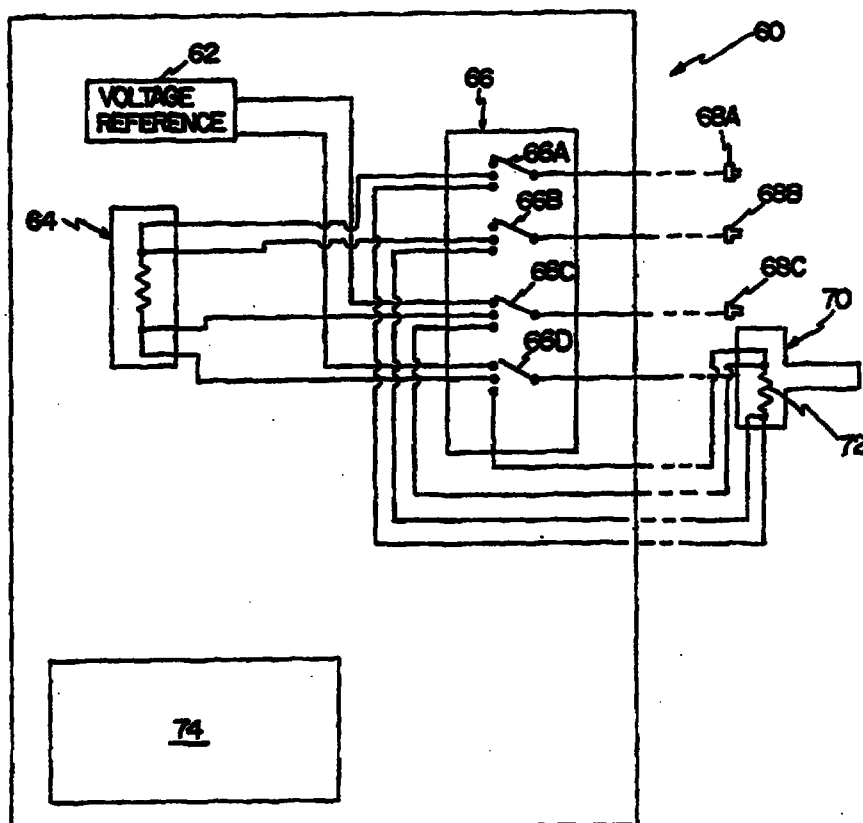
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(54) Title: CALIBRATION OF PROCESS CONTROL TEMPERATURE TRANSMITTER

(57) Abstract

A transmitter (10) in a process control loop (12) measures temperature. A calibrator (60) includes a known calibration element (64) which is connected to the transmitter (10). Software in the transmitter (10) compares a measured value of the calibration element (64) with the actual value of the calibration element (64) and responsively calibrates the transmitter (10). The calibrator (60) includes a temperature calibration sensor (70) for coupling to a terminal block (14) of the transmitter (10). The temperature calibration sensor (70) provides an actual temperature input to the transmitter (10). The transmitter (10) measures actual temperature of the terminal block (14) and compares actual temperature with a temperature measured by an internal terminal block temperature sensor (34), and responsively calibrates the internal temperature sensor (34).



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CALIBRATION OF PROCESS CONTROL**TEMPERATURE TRANSMITTER**

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BACKGROUND OF THE INVENTION

The present invention relates to transmitters used in process control loops. More specifically, the present invention relates to calibrating temperature transmitters used in process control loops.

Process control transmitters are used to measure process parameters in a process control system. Microprocessor based transmitters include a sensor or sensor input, an analog-to-digital converter for converting an output from the sensor into a digital format, a microprocessor for compensating the digitized output, and an output circuit for transmitting the compensated output. Typically, this transmission is over a process control loop, such as a 4-20 mA current loop. One example parameter is temperature, which is sensed by measuring the resistance of an RTD (Resistive Temperature Device, also called a PRT, Platinum Resistance Thermometer) sensor, or the voltage output of a thermocouple sensor.

One technique for sensing the parameter is by comparison of the resistance of an RTD with an internal reference resistance level in the transmitter which is calibrated when the transmitter is manufactured. For example, resistance of the RTD is measured by connecting it in series with a known reference resistance (R_{REF}) and

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applying a current common to both resistances. The resistance of the sensor (R_{INPUT}) is expressed as follows:

$$R_{INPUT} = \frac{V_{R INPUT}}{V_{R REF}} \times (R_{REFNOM} + R_{CAL1} + R_{CAL2}) \quad \text{Equation 1}$$

5

where:

R_{REFNOM} = the nominal resistance of the reference resistance in ohms;

10 R_{CAL1} = a calibration offset in ohms determined during manufacture. This value represents the difference between the calibrated reference resistance (R_{REF}) and the nominal value of the reference resistance;

15 R_{CAL2} = a user calibration offset;

$V_{R INPUT}$ = voltage drop across the input; and

$V_{R REF}$ = voltage drop across R_{REF} .

Equation 1 is used as part of an auto-zeroing and auto-spanning routine in that errors in measurement of $V_{R INPUT}$ in the numerator tend to be the same as errors in $V_{R REF}$ in the denominator and therefore cancel.

The A/D converter digitizes the voltages of Equation 1. The microprocessor receives the digitized values and calculates and compensates R_{INPUT} according to Equation 1 which is converted into a corresponding sensor temperature value with a look-up table or suitable equation by the microprocessor. The output circuit in the transmitter receives the sensor temperature value and provides an output to the loop as a current level or as a digital value. Unfortunately, R_{REF} sometimes drifts from the calibrated value of R_{REFNOM} and R_{CAL1} , leading to inaccuracies in measurement of temperature.

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A typical prior art method of calibrating the R_{REF} is to connect an external predetermined resistance to the sensor input of the transmitter and have the transmitter enter a calibration mode. The transmitter
5 compares the expected value of the predetermined resistance with the measured value of the R_{INPUT} and uses the difference to calibrate its electronics by adjusting R_{CAL2} , the user trim. Typically, the predetermined resistance is an active circuit or a resistance decade
10 box. Active circuitry which simulates resistance is usually inaccurate and typically incompatible with an intrinsically safe environment. Decade boxes are unrepeatable and inaccurate relative to precision transmitters and are unwieldy, requiring the transmitter
15 to be disconnected from the process loop in the field and brought into a calibration lab. They also suffer from drift in resistance value from changes in ambient temperature.

Thermocouples are also used by transmitters to
20 measure temperature. U.S. Patent No. 4,936,690, entitled "Thermocouple Transmitter with Cold Junction Compensation," and assigned to the same assignee as the present application, describes such a measurement. A thermocouple junction generates a voltage across the
25 junction related to its temperature. However, a junction between dissimilar metals at the terminal block of the transmitter introduces another thermocouple voltage. To measure the thermocouple temperature, it is
30 necessary to measure the temperature of this "cold junction" at the terminal block connection and compensate for this voltage. Typically, in microprocessor based transmitters, a temperature sensor is thermally coupled to the terminal block and connected to the microprocessor of the transmitter through the A/D

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converter. The microprocessor compensates the thermocouple voltage based upon the cold junction temperature measured by the PRT. Errors in thermocouple temperature measurements arise if the transmitter
5 inaccurately measures the temperature at the cold junction.

Prior art attempts at calibrating thermocouple multiple input transmitters focus on calibrating the transmitter with a known voltage source. However, the
10 source has typically been relatively unstable with respect to a precision transmitter. For example, a precision thermocouple transmitter has a typical accuracy of 0.04 percent of the actual value. Further, little attention has been given to calibrating the cold
15 junction temperature measurement.

The art lacks a self-contained calibration device for adequately calibrating temperature measurements. Further, the art lacks a device that is stable enough to be effectively traceable to a NIST
20 (National Institute of Standards Technology) traceable reference within the precision of a high precision transmitter. As with RTD's, voltage calibrations are inaccurate and not stable enough to be useful as NIST traceable devices (e.g., they are not stable enough to
25 hold their calibration for very long).

SUMMARY OF THE INVENTION

The present invention is a temperature transmitter which transmits a measured temperature over a process control loop. To calibrate the transmitter,
30 a known NIST traceable resistance R_{NIST} is coupled to the input of the transmitter, which the transmitter measures as R_{INPUT} . The NIST calibrated value of R_{NIST} ($R_{NISTCAL}$) is provided to the microprocessor of the transmitter which then responsively calculates a calibration value R_{CAL3}

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for use in subsequent measurement of R_{INPUT} and temperature. In a different calibration mode, the transmitter is coupled to a known NIST traceable voltage reference V_{NIST} which the transmitter measures. The NIST
5 calibrated value of V_{NIST} (V_{NISTCAL}) is provided to the transmitter input circuitry and the transmitter responsively calculates a voltage calibration value V_{CAL3} . In a final calibration mode, a temperature probe that may have NIST traceable calibration is coupled to
10 the terminal block of the transmitter, and the transmitter measures the cold junction temperature and then responsively calibrates an internal cold junction temperature sensor.

A calibrator adapted for coupling to the
15 transmitter includes the NIST traceable resistance R_{NIST} , the NIST traceable voltage V_{NIST} and the NIST traceable temperature probe (P_{NIST}). In one embodiment, the calibrator communicates with the transmitter over the two-wire process control loop.

20 BRIEF DESCRIPTION OF THE DRAWINGS

Figure 1A is a block diagram of a temperature transmitter connected to measure temperature with an RTD sensor.

Figure 1B is a block diagram, like Figure 1A,
25 of a temperature transmitter connected to measure temperature with a thermocouple sensor.

Figure 2 is a block diagram of one embodiment of a calibrator.

Figure 3 is a block diagram of another
30 embodiment of a calibrator.

Figure 4 is a diagram which shows a calibrator coupled to a transmitter.

Figure 5 is a flow chart of operation of a microprocessor in the temperature transmitter.

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DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

Figure 1A is a block diagram of temperature transmitter 10 connected to measure temperature with an RTD sensor. Transmitter 10 couples to process control loop 12 which provides power to transmitter 10 and over which information is transmitted and received. Transmitter 10 includes terminal block 14 having terminals 1 through 4 for coupling to, for example, an RTD temperature sensor 16 or a thermocouple temperature sensor 18 (shown in Figure 1B). Figure 1A shows the electrical connections to RTD 16. Sensor 16 (and sensor 18) can be either internal or external to transmitter 10. Transmitter 10 includes multiplexer 20 controlled by microprocessor 22 which is coupled to control loop 12 through input/output (I/O) circuitry 24. Multiplexer 20 multiplexes appropriate sets of analog signals, including signals from terminals 1 through 4, to positive and negative inputs of differential amplifier 26, which connects to high accuracy A/D converter 28. In one embodiment, converter 28 has an accuracy of 17 bits and a conversion rate of 14 samples/second. One example conversion technique is described in "Resolve 22 Bits Easily with Charge-Balance ADC's," by Thomas J. Mego, published June 25, 1987, in Electronic Design Magazine, page 109. Memory 30 stores instructions and information for microprocessor 22, which operates at a speed determined by clock 32. Multiplexer 20 selectively connects its inputs to the positive or negative inputs of differential amplifier 26. A resistance 38 couples to multiplexer 20 and is connected in series with RTD 16.

In operation, transmitter 10 measures temperature of sensor 16 and transmits a representation of temperature over control loop 12. Transmitter 10

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employs the following equation to compute the temperature of RTD 16:

$$R_{INPUT} = \frac{V_{RINPUT}}{V_{RREF}} (R_{REFNOM} + R_{CAL1} + R_{CAL2} + R_{CAL3}) \quad \text{Equation 2}$$

5

where:

- R_{REFNOM} = the nominal resistance of the reference resistance in ohms, and/or stored in memory 30;
- 10 R_{CAL1} = a calibration offset to R_{REFNOM} in ohms determined during manufacture, and/or stored in memory 30. This value represents the difference between the actual value of the reference resistance
- 15 (R_{REF}) and the nominal value of the reference resistance at manufacture;
- R_{CAL2} = a user calibration offset to R_{REFNOM} stored in memory 30;
- R_{CAL3} = a field calibrated offset to R_{REFNOM} in accordance with one aspect of the invention, stored in memory 30;
- 20 V_{RINPUT} = voltage drop across the input; and
- V_{RREF} = voltage drop across R_{REF} .

Current source 50 provides current I_s through sensor 16 (via terminals 1 and 4) and reference resistor 38. Microprocessor 22 measures the voltage drop (V_{RINPUT}) across RTD 16 between terminals 2 and 3, and the voltage drop (V_{RREF}) across resistor 38 with MUX 20. R_{REFNOM} , R_{RCAL1} , R_{RCAL2} and R_{RCAL3} are retrieved from memory 30. R_{CAL3} is used to accurately calibrate the measurement to a NIST standard as described below. In a four-wire resistance measurement such as this, the voltage drop across the connections to terminals 2 and 3 is largely

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eliminated, since substantially all the current flows between terminals 1 and 4, and has little impact on the accuracy of the measurement. R_{INPUT} is converted to temperature units with a look-up table or suitable equation stored in memory 30. The improved accuracy of the invention is partially achieved by using additional calibration data stored in memory and additional computational power of the microprocessor.

Figure 1B shows transmitter 10 connected to measure temperature with thermocouple sensor 18 which creates a voltage V_{TCINPUT} across terminals 1 and 2. Multiplexer 20 couples inputs of differential amplifier 26 to terminals 2 and 1. Figure 1B shows a voltage reference (V_{TCREF}) 36 coupled to MUX 20 and current source 50. A voltage reference 36 includes resistors 40 and 42 connected as a voltage divider and a Zener diode 44.

Transmitter 10 measures the temperature of thermocouple sensor 18 by determining the thermocouple voltage V_{TC} with the following equation:

$$V_{\text{TC}} = \frac{V_{\text{TCINPUT}}}{V_{\text{TCREF}}} (V_{\text{TCREFNOM}} + V_{\text{CAL1}} + V_{\text{CAL2}} + V_{\text{CAL3}}) \quad \text{Equation 3}$$

where:

- 25 V_{TCINPUT} = the measured voltage across terminals 1 and 2 of terminal block 14 sensed by amplifier 26;
- V_{TCREF} = the measured voltage generated by voltage reference 36 as sensed by amplifier 26;
- 30 V_{TCREFNOM} = a nominal value of voltage reference 36 stored in memory 30;

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V_{CAL1} = a factory calibration offset to $V_{TCREFNOM}$ placed in memory 30 during manufacture of transmitter 10;

V_{CAL2} = a user trim calibration offset to $V_{TCREFNOM}$ stored in memory 30; and

V_{CAL3} = a calibration offset to $V_{TCREFNOM}$ stored in memory 30 for calibrating transmitter 10 to a NIST traceable voltage reference.

However, the junction between two dissimilar metals formed at terminal 1 introduces a cold junction error voltage proportional to the temperature of the junction. The error voltage is sensed by measuring the temperature of the junction at terminal 1 based upon the resistance of a PRT (Platinum Resistance Thermometer) sensor 34 and subsequently using a standard equation or look-up table to determine the cold junction error voltage. Resistance of sensor 34 is measured using Equation 2 by applying a current I_s from with current source 50. The resistance of PRT sensor 34 is calculated as:

$$R_{CJCPRT} = R_{PRT EQ.2} + R_{PRTCAL} \quad \text{Equation 4}$$

where:

R_{CJCPRT} = the calibrated resistance of PRT sensor 34;

$R_{PRT EQ.2}$ = the resistance of PRT as calculated with Equation 2; and

R_{PRTCAL} = a calibration offset stored in memory 30.

Microprocessor 20 computes V_{TC} according to Equation 3 and R_{CJCPRT} according to Equation 4, then effectively

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subtracts R_{CICPRT} from V_{TC} using an appropriate look-up table or equation. Then the resulting compensated temperature of sensor 18 is coupled to loop 12 via output circuitry 24.

5 Figure 2 is a schematic diagram of a calibrator 60 in accordance with the invention. Calibrator 60 includes a voltage reference (V_{NIST}) 62, resistor reference (R_{NIST}) 64, compound switch 66, connectors 68a, 68b and 68c, and connector/probe 70
10 which includes a NIST traceable PRT sensor 72. R_{NIST} should be selected as a high accuracy resistance which is stable over time and temperature. Similarly, V_{NIST} should be an accurate voltage reference stable over time and temperature, such as a voltage drop across a
15 temperature and time stable diode. Switch 66 includes ganged switches 66a through 66d which are operated in unison and selectively couple connectors 68a through 68c and connector/probe 70 to reference resistor 64, voltage reference 62 and PRT sensor 72, respectively. Probe 70
20 is adapted for thermally coupling to terminal block 14 of transmitter 10. In one embodiment, probe 70 screws into terminal block 14.

In operation, V_{NIST} 62 and R_{NIST} 64 and probe 70 are calibrated to a NIST traceable reference using a
25 standard laboratory NIST traceable volt/ohm meter and a temperature standard calibrated 0°C ice point. The precise calibrated values of reference voltage 62 ($V_{NISTCAL}$), reference resistance 64 ($R_{NISTCAL}$) and $P_{NISTCAL}$ (NIST calibrated value of R_{PROBE} at 0°C) are marked on
30 labeling 74 on calibrator 60. Calibrator 60 is taken to the location of transmitter 10 and connectors 70, 68c, 68b and 68a are connected to terminals 1, 2, 3 and 4, respectively. Switch 66 is operated to connect one end of resistor R_{NIST} 64 to terminals 1 and 2 and terminal

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block 14. In this position, R_{NIST} 64 is connected in a manner similar to RTD 16, shown in Figure 1A. Transmitter 10 receives a command (such as a HART® command) over loop 12 which instructs transmitter 10 to enter a calibration mode and an operator provides transmitter 10 with the NIST calibrated value ($R_{NISTCAL}$) of R_{NIST} 64, as indicated on labeling 74. This information is provided to transmitter 10, for example, over two-wire loop 12 using a hand held communicator such as that described in U.S. Patent No. 4,988,990, entitled "Dual Master Implied Token Communication System." Microprocessor 22 causes V_{RINPUT} and V_{REFNOM} to be sensed and digitized, and calculates a new value of R_{CAL3} , $R_{CAL3(NEW)}$, as follows:

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$$R_{CAL3(NEW)} = R_{NISTCAL} \frac{V_{RREF}}{V_{RINPUT}} - R_{REFNOM} - R_{CAL1} - R_{CAL2} \quad \text{Equation 5}$$

$R_{CAL3(NEW)}$ is stored in memory 30 as R_{CAL3} for subsequent measurements.

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Next, the operator positions switch 66 to couple voltage reference V_{NIST} 62 between terminals 1 and 2 of terminal block 14 as $V_{TCINPUT}$. The NIST calibrated value ($V_{NISTCAL}$) of the V_{NIST} 62 is provided to transmitter 10 over 12. A new value of V_{CAL3} ($V_{CAL3(NEW)}$) is determined:

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$$V_{CAL3(NEW)} = V_{NISTCAL} \frac{V_{TCREF}}{V_{TCINPUT}} - V_{TCREFNOM} - V_{CAL1} - V_{CAL2} \quad \text{Equation 6}$$

$V_{CAL3(NEW)}$ is stored in memory 30 for subsequent use as V_{CAL3} .

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After calibrating resistance and voltage measurements, cold junction temperature sensor 34 is calibrated by placing switch 66 in position to couple the other end of PRT sensor 72 to terminals 1 and 2, and

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the other end to terminals 3 and 4. Probe/connector 70 is thermally coupled to terminal 1 proximate sensor 34 such that the temperature of PRT sensor 72 is substantially the same as the temperature of PRT internal sensor 34. For example, probe 70 can screw into terminal 1. Transmitter 10 receives the probe NIST value $P_{NISTCAL}$ and initiates PRT calibration by measuring resistance R_{PROBE} of PRT sensor 72 and resistance R_{CJCPR} PRT sensor 34 and by using Equation 2. In one embodiment, microprocessor 22 compares the difference in these measurements which represents the amount sensor 34 has drifted from its previously calibrated value. This provides a new cold junction calibration value $R_{PRTCAL(NEW)}$ as follows:

$$R_{PRTCAL(NEW)} = R_{PROBE} - R_{CJCPR} + (P_{NOM} - P_{NIST}) \quad \text{Equation 7}$$

where P_{NOM} is the nominal resistance of a standard PRT at 0°C. $R_{PRTCAL(NEW)}$ is stored in memory 30 as R_{PRTCAL} .

Figure 3 is a block diagram of a calibrator 80 in accordance with another embodiment. Calibrator 80 includes reference resistance (R_{NIST}) 64, voltage reference (V_{NIST}) 62, NIST traceable probe P_{NIST} 70, and connectors 68a, 68b, 68c and 70. Microprocessor 82 controls calibrator 80. Microprocessor 82 displays information on display 84, stores information in memory 88, receives information from an operator through keypad 90, and communicates over two-wire loop 12 through input/output circuitry 92. Microprocessor 82 selectively couples R_{NIST} 64, V_{NIST} 62 and PRT sensor 72 (not shown in Figure 3) to connectors 68a through 68c and 70 using multiplexer 94 which operates similarly to switch 66, shown in Figure 2.

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In operation, an operator measures references 62 and 64 and probe 70 relative to a NIST traceable volt/ohm meter and temperature standard, and enters these values ($R_{NISTCAL}$, $V_{NISTCAL}$ and $P_{NISTCAL}$) into memory 88 using microprocessor 82 and keypad 90. Calibrator 80 is connected to transmitter 10, through connectors 68a through 68c and 70, and couples to loop 12 through input/output circuitry 92 so that calibrator 80 communicates directly with transmitter 10 pursuant to standard communication techniques such as the HART® protocol. An operator instructs calibrator 80 to begin calibration by entering a command on keypad 90. Microprocessor 82 controls multiplexer 94 to connect voltage reference 64 to transmitter 10. Microprocessor 82 instructs microprocessor 22 of transmitter 10 to enter a calibration mode by sending an appropriate command through I/O circuitry 92 over two-wire loop 12. Microprocessor 82 sequentially connects resistance 64 and voltage reference 62 to transmitter 10 through MUX 94 and instructs microprocessor 20 to calibrate resistance and voltage, as disclosed above. Temperature sensor 34 in terminal block 14 is calibrated using sensor 72 (not shown in Figure 3) which is coupled to transmitter 10 through multiplexer 94 and $R_{PRTCAL(NEW)}$ is determined. In one embodiment, transmitter 10 communicates the amount that its reference values have drifted for display in accordance with ISO 9000 requirements. This can be displayed on a hand held communicator or displayed on calibrator 80.

Figure 4 is a block diagram of a process control system 100 including transmitter 10, loop 12, and controller electronics 102 which are modeled as resistance 104 and voltage source 106. Figure 4 shows calibrator 80 coupled to loop 12 and to RTD sensor 16

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through junction box 108 which receives a connector 110. Junction box 108 is an alternative to individually screwing connectors 68a, 68b, 68C and 70 into terminal block 14. Junction box 108 allows calibrator 90 to
5 directly couple to terminal block 14 through connector 110. Plugging connector 110 into junction box 108 actuates switches 112, thereby providing electrical connections to terminals 1 through 4 of terminal block 14 and electrically disconnecting sensor 16. To perform
10 a cold junction temperature sensor calibration, sensor 70 is attached to terminal 1 of terminal block 14. Junction box 108 provides a simple and convenient technique of accessing terminals 1 through 4 of terminal block 14. As resistance measurements are made using a
15 four-wire connection, resistance introduced through switches 112 does not reduce the calibration accuracy.

Figure 5 is a flow chart 140 showing operation of microprocessor 22 according to instructions in memory 30. Flow chart 140 normally operates in loop 142 which
20 includes measuring and transmitting temperature over two-wire loop 12 at block 144 and checking for a calibration initiation command received over loop 12 at block 146. Upon receipt of a calibration command, microprocessor 22 begins calibration at block 148.

25 Determination of $R_{CAL3(NEW)}$ is initiated at block 148. Prior to sending a command to begin calibration, an operator has connected the NIST traceable resistance to terminal block 14. At block 148, microprocessor 22 measures and transmits R_{NIST} over process control loop
30 12. The transmitted value of R_{NIST} can be displayed on a hand held communicator or on calibrator 80. At block 150, microprocessor 22 obtains the value of $R_{NISTCAL}$ over loop 12 from calibrator 80. At block 152, the values of R_{INPUT} and R_{REF} are measured and a new calibration value

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$R_{CAL3(NEW)}$ is calculated and stored at block 154, according to Equation 5. At block 156, R_{NIST} is again measured and its value is transmitted over loop 12 for receipt by a hand held unit or by calibrator 80. This value should be approximately the same as the value of $R_{NISTCAL}$.

Next, an operator connects the NIST traceable voltage reference to terminal block 14 for calculation of $V_{CAL3(NEW)}$. V_{NIST} is measured and transmitted over two-wire loop at block 158. Microprocessor 22 obtains $V_{NISTCAL}$ from calibrator 80 over loop 12 and $V_{TCINPUT}$ and V_{TCREF} at block 160. At block 162, a value of $V_{CAL3(NEW)}$ is calculated according to Equation 6 and stored in memory. V_{NIST} is again measured and its value is transmitted over loop 12 at block 164. This value should be approximately the same as $V_{NISTCAL}$. This completes calibration of voltage measurement, and probe 70 is connected to terminal block 14 for calibration of PRT sensor 34. At block 166, determination of $R_{PRTCAL(NEW)}$ is initiated and the value of $P_{NISTCAL}$ is obtained by microprocessor 22 at block 166 from calibrator 80 over loop 12. At block 168, microprocessor 22 measures P_{PROBE} and R_{PRT} . At block 170, microprocessor 22 calculates $R_{PRTCAL(NEW)}$ using Equation 7, and this value is stored in memory 30. Block 172 shows the completion of the calibration procedure and control is returned to block 144.

Although the present invention has been described with reference to preferred embodiments, workers skilled in the art will recognize that changes may be made in form and detail without departing from the spirit and scope of the invention. For example, other types of references may be used and communication of the actual values of these references may be through

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any appropriate means. For example, although the calibration procedures described were explained with reference to two-wire transmitters, three- and four-wire transmitters can equally well make use of the inventions. For example, although four-wire resistance measurement has been described, the concepts set forth herein are applicable to two- or three-wire resistance measurement.

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WHAT IS CLAIMED IS:

1. A temperature transmitter in a process control loop, comprising:
 - a sensor input for receiving a temperature calibration input resistance from a temperature sensor for cold junction composition calibration;
 - a reference temperature sensor for measuring resistance of a cold junction of the sensor input;
 - A/D conversion circuitry for converting the sensor input and the measured resistance into digital values;
 - I/O circuitry coupling to the process control loop and sending and receiving information over the loop; and
 - microprocessor circuitry coupled to the A/D converter for calibrating the reference temperature sensor in response to the calibration input resistance.
2. The transmitter of claim 1 wherein the calibration input is NIST traceable.
3. The transmitter of claim 1 including a resistance coupled in series with the reference temperature sensor and wherein the microprocessor determines cold junction temperature based upon voltage drop across the resistance.
4. A temperature transmitter in a process control loop, comprising:
 - a terminal block for coupling to a sensor resistance;
 - a current source providing a current through the sensor resistance and through a



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reference resistance coupled in series with the sensor resistance;

an A/D converter which converts voltage differences across the sensor resistance and the reference resistance into digital values;

I/O circuitry for sending and receiving information;

memory containing a value of the reference resistance R_{REF} and a resistance calibration value R_{CAL3} ; and

a microprocessor receiving an actual value of the sensor resistance from the I/O circuitry, the digital values of the voltage differences across the sensor resistance and the reference resistance, and the value of the reference resistance R_{REF} from memory and responsively calculating a new calibration value $R_{CAL3(NEW)}$, wherein $R_{CAL3(NEW)}$ is stored in the memory as R_{CAL3} for subsequent use during temperature measurements.

5. The temperature transmitter of claim 4 wherein the terminal block is adapted for coupling to a thermocouple providing a thermocouple voltage, the memory contains a voltage calibration value V_{CAL3} and the microprocessor receives an actual value V_{ACTUAL} of the thermocouple voltage, a sensed thermocouple voltage from the A/D converter, and the voltage calibration value V_{CAL3} and responsively calculates a new voltage calibration value $V_{CAL3(NEW)}$, wherein $V_{CAL3(NEW)}$ is stored in the memory as V_{CAL3} for subsequent use during temperature measurements.



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6. The temperature transmitter of claim 4 including a CJC temperature sensor thermally coupled to the terminal block providing a terminal block temperature sensor output R_{CJCPRT} , and the microprocessor calculates a calibration offset $R_{PRTCAL3(NEW)}$ in response to the terminal block temperature sensor output R_{CJCPRT} and a probe thermally coupled to the terminal block which provides a resistance R_{PROBE} received by the I/O circuitry, and the calibration offset is stored in the memory for subsequent use during temperature measurements.

7. The temperature transmitter of claim 6 wherein the probe resistance R_{PROBE} is electrically coupled to the terminal block.

8. The temperature transmitter of claim 4 including a junction box for electrically coupling the sensor resistance to the terminal block.

9. A calibrator for calibrating a temperature transmitter in a process control loop, comprising:

- a NIST traceable reference;
- a plurality of electrical connectors adapted for electrically connecting to a terminal block of the transmitter; and
- a switch connected for selectively coupling the NIST traceable reference to the plurality of electrical connectors.

10. The calibrator of claim 9 wherein the NIST traceable reference is a NIST traceable resistance.

11. The calibrator of claim 9 wherein the NIST traceable reference is a NIST traceable voltage.

12. The calibrator of claim 9 wherein the NIST traceable reference is a temperature probe.

13. The calibrator of claim 9 including circuitry for coupling to the process control loop and





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transmitting values of the NIST traceable reference to the transmitter.

14. The calibrator of claim 9 including a NIST traceable temperature probe adapted for coupling to the terminal block and measuring a cold junction temperature.

15. A method of calibrating a temperature transmitter in a process control loop, comprising:

connecting an input of the transmitter to a NIST traceable reference;

communicating the value of the NIST traceable reference to the transmitter;

comparing the communicated value of the NIST traceable reference with a measured value of the NIST traceable reference; and

responsively calibrating the temperature transmitter based upon the comparison.

16. The method of claim 15 wherein the step of communicating comprises transmitting information over the process control loop to the transmitter.

17. The method of claim 15 including transmitting the communicated value of the NIST traceable reference prior to calibrating and transmitting the measured value of the NIST traceable reference after calibration.

18. The method of claim 15 including:
measuring temperature of a terminal block of the transmitter;
communicating the measured temperature to the transmitter;

comparing communicated temperature with an internally measured terminal block temperature; and



* C L M S *



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calibrating the transmitter based upon the comparison.

19. The method of claim 15 wherein the NIST traceable reference is a resistance.
20. The method of claim 15 wherein the NIST traceable reference is a voltage.
21. The method of claim 15 wherein the NIST traceable reference is a temperature probe.
22. A junction box, comprising:
 - first connections for coupling to a terminal block of a transmitter in a process control system;
 - second connections for coupling to a sensor;
 - a calibration input for coupling to a reference element;
 - a switch movable between a first position in which the first connections are coupled to the second connections and a second position in which the first connections are coupled to the calibration input.
23. The junction box of claim 22 wherein the switch is actuated when the reference element is connected to the calibration input.
24. The junction box of claim 22 wherein the second connections and the calibration input include four connections for a four-wire resistance measurement.



* C L M S *

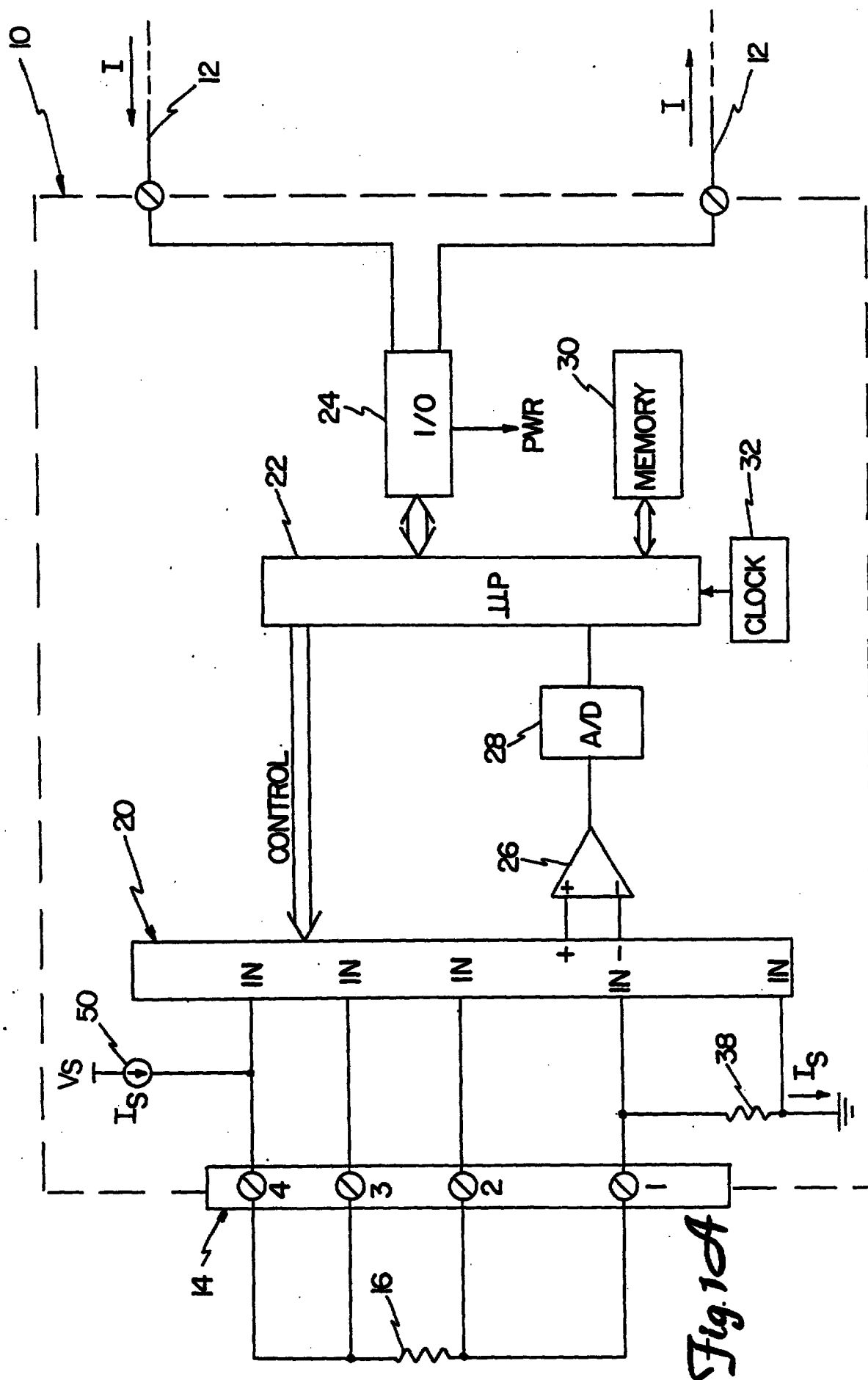


Fig. 10A

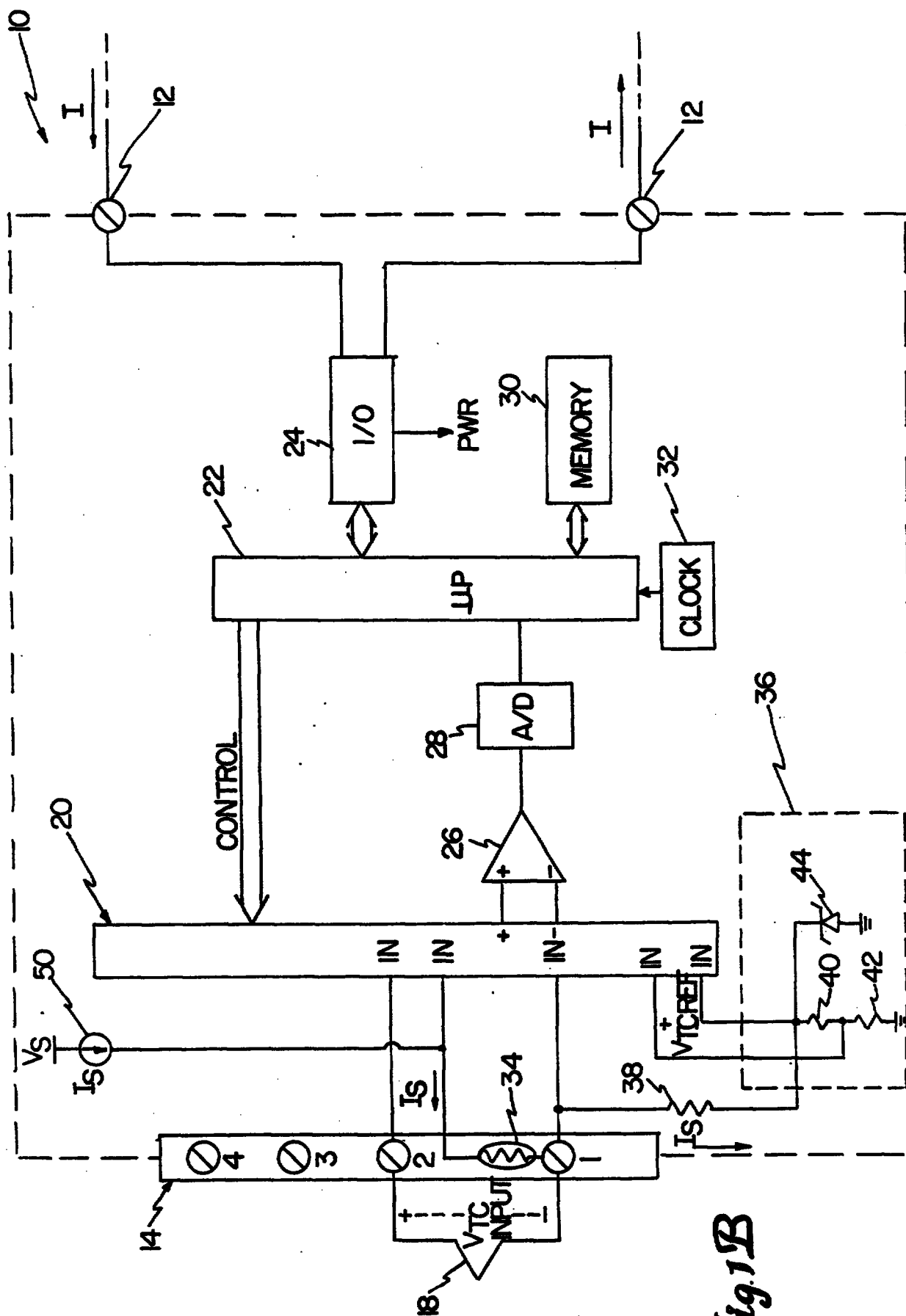


Fig. 1B

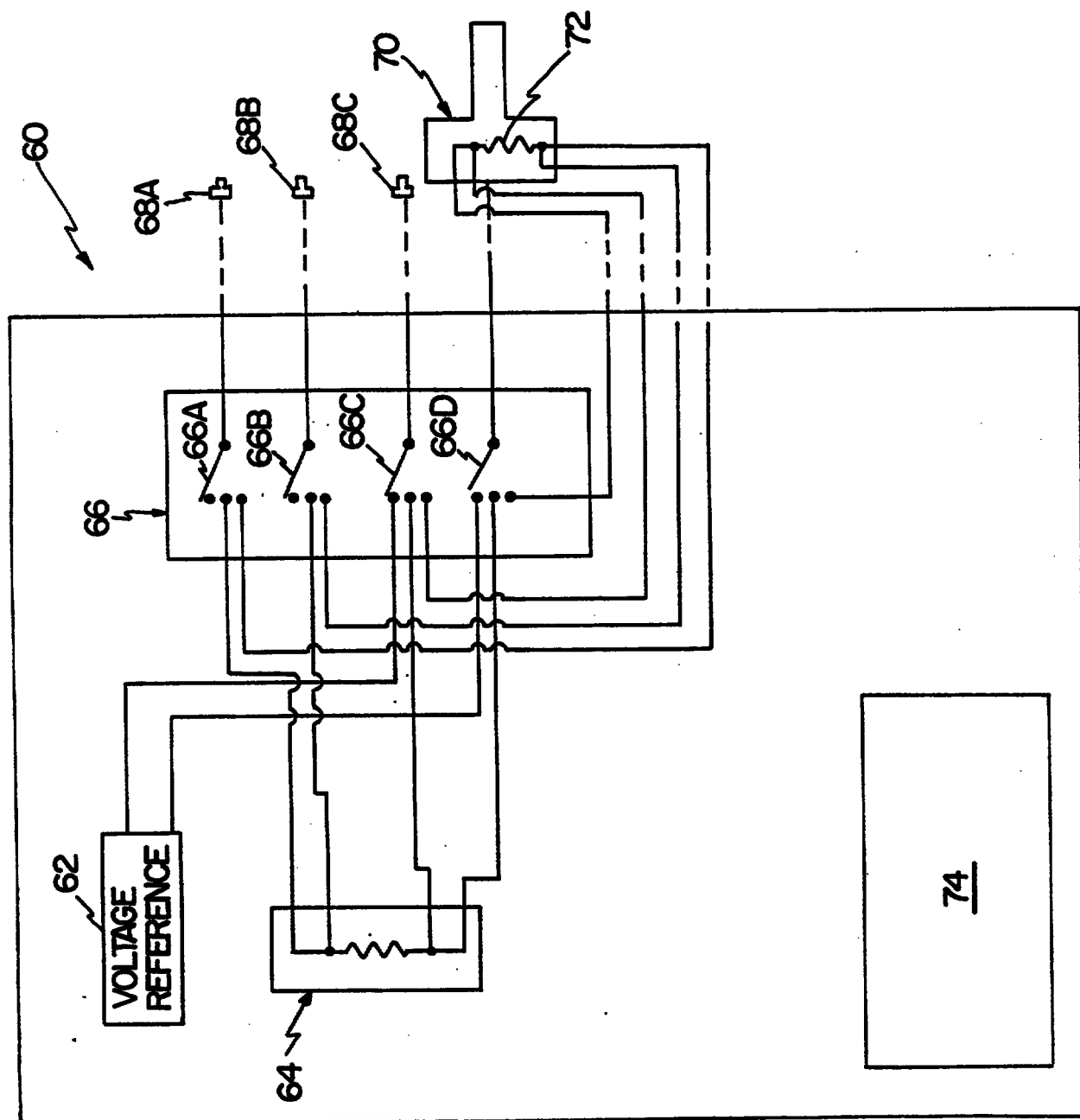


Fig. 2

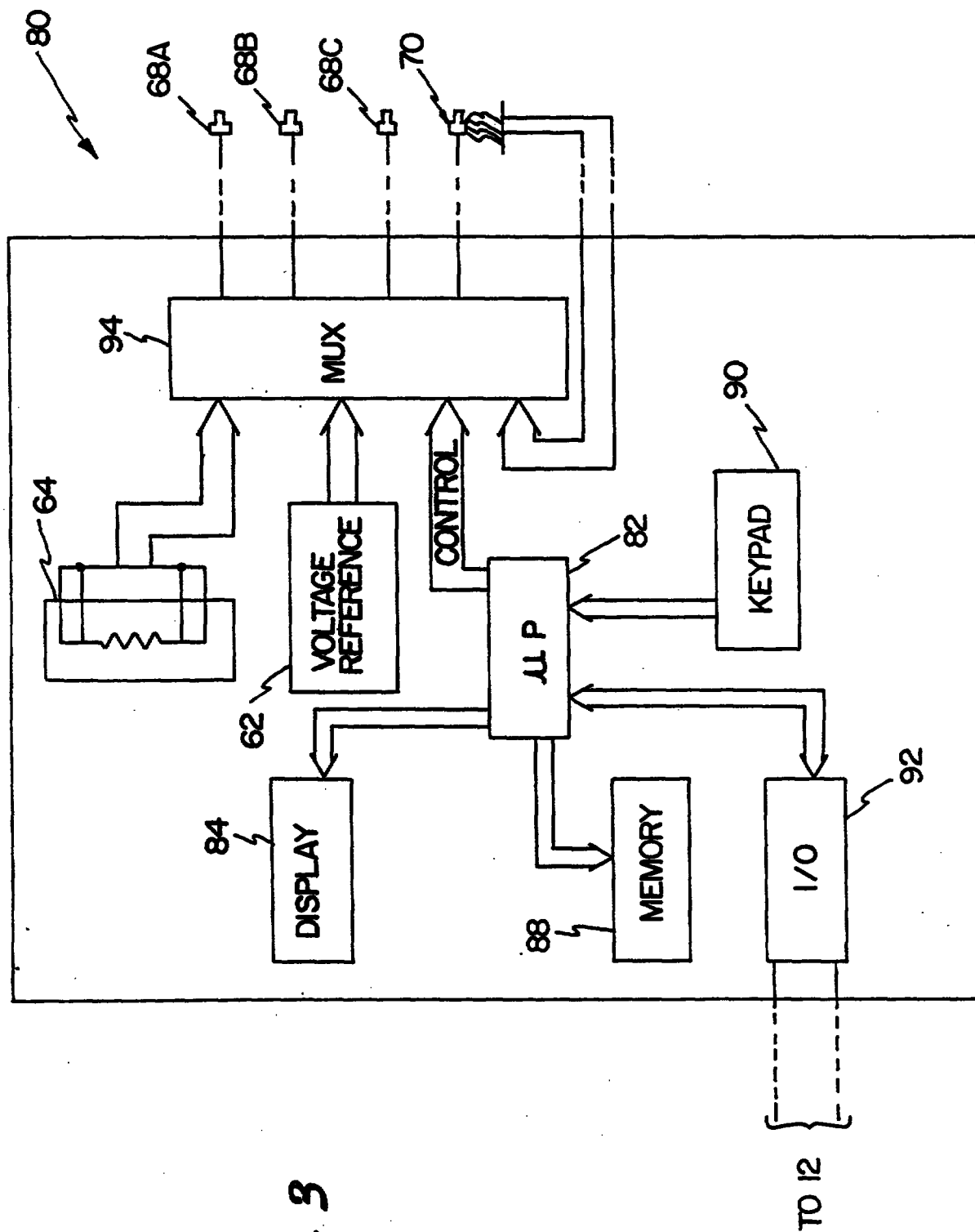


Fig. 3

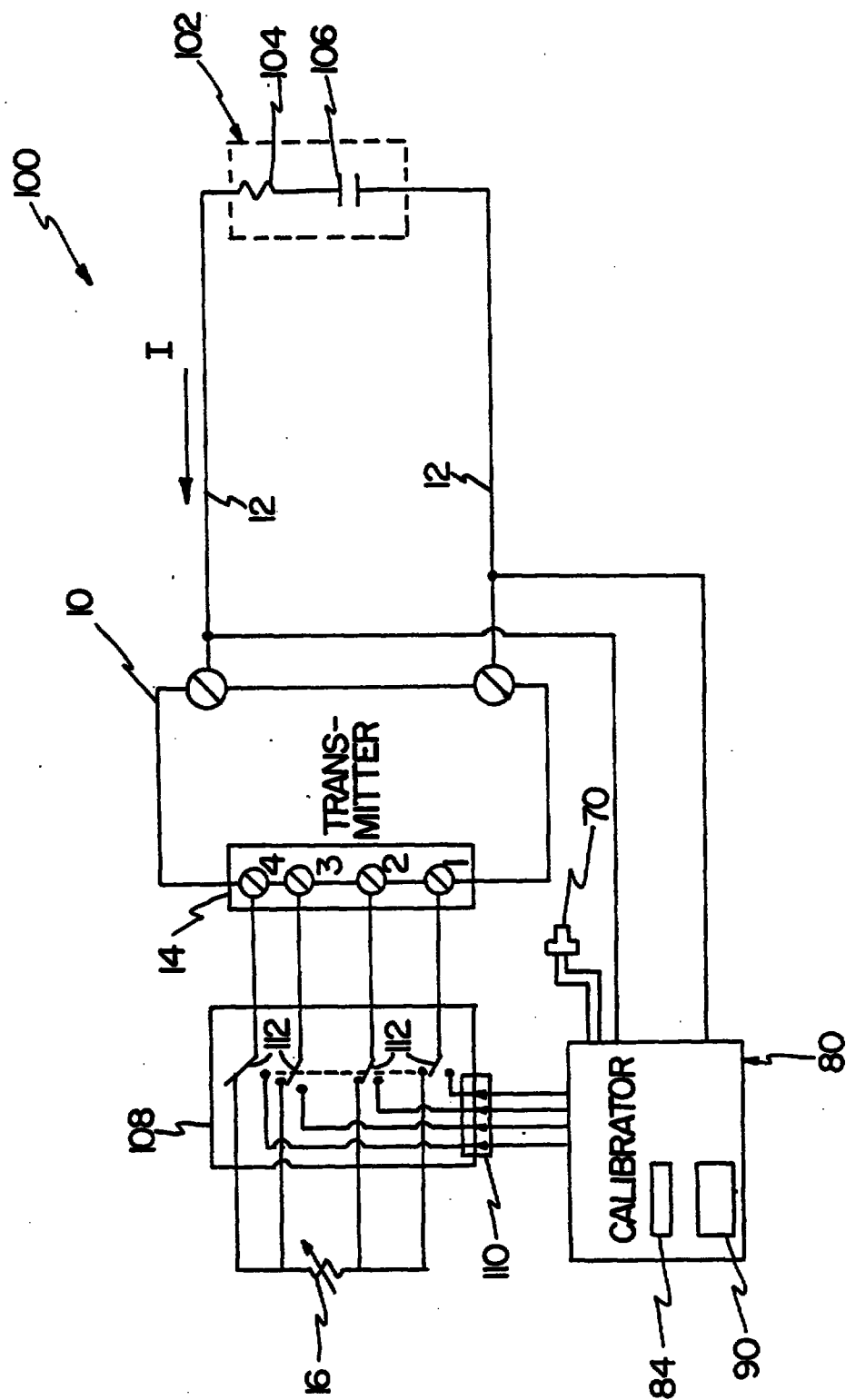


Fig. 4

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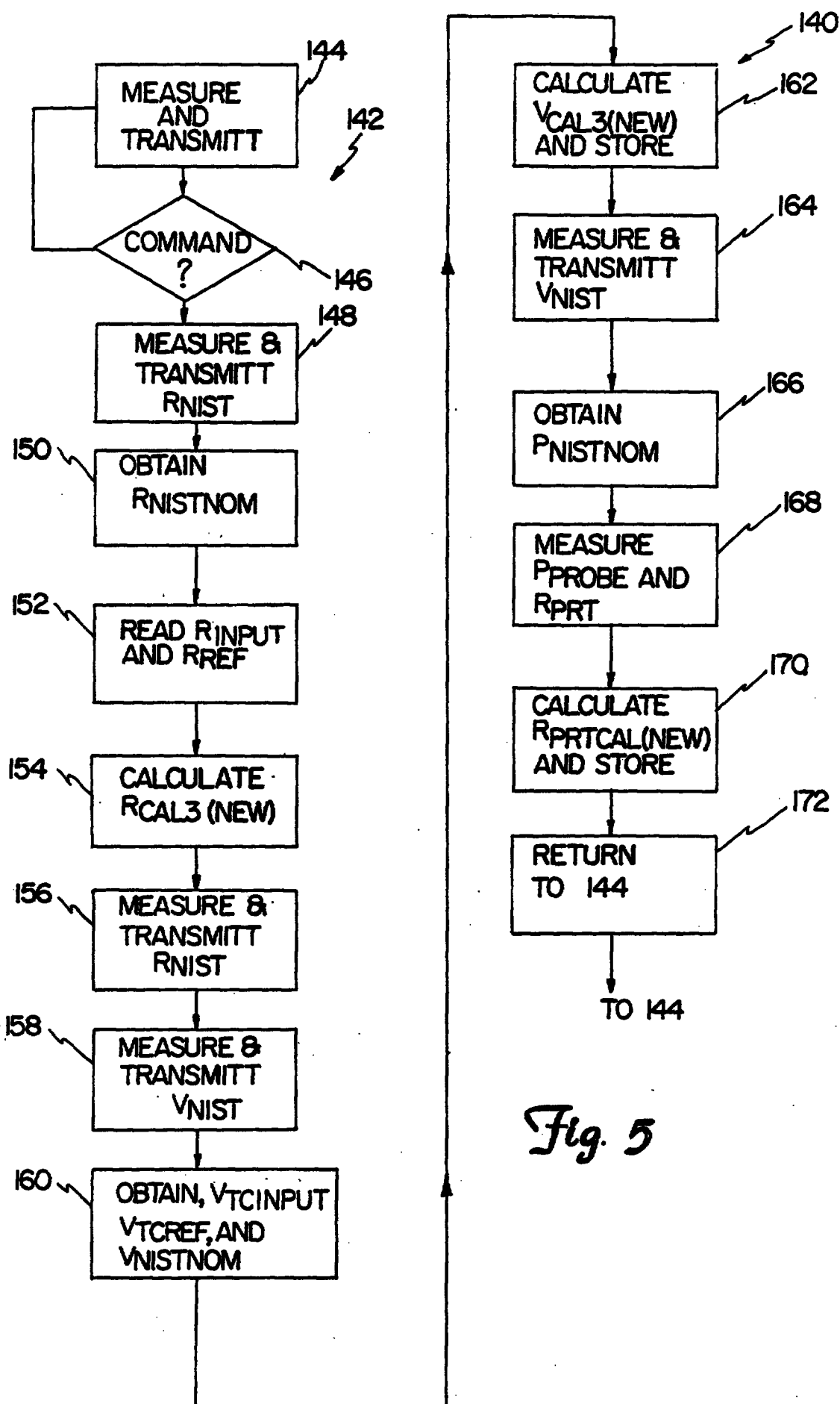


Fig. 5